

**Notice of References Cited**

Application/Control No.

09/893,566

Applicant(s)/Patent Under  
Reexamination  
PARK ET AL.

Examiner

Jennifer T Nguyen

Art Unit

2674

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,867,139	02-1999	Tanaka et al.	345/92
	B	US-5,940,055	08-1999	Lee	345/87
	C	US-5,745,090	04-1998	Kim et al.	345/90
	D	US-4,955,697	09-1990	Tsukada et al.	350/332
	E	US-5,285,301	02-1994	Shirahashi et al.	359/59
	F	US-6,130,654	10-2000	Hayashi et al.	345/63
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.